

General Description

The UV30P10MS uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge.

This device is suitable for use in PWM, load switching and general purpose applications.

Features

Enhancement Mode

Enhanced Body diode dv/dt capability

100% Avalanche Tested

| | | |
|------------------------------|-------|-----------|
| V_{DS} | -30 | V |
| $R_{DS(on)type}@V_{GS}=10V$ | -12 | $m\Omega$ |
| $R_{DS(on)type}@V_{GS}=4.5V$ | -16.5 | $m\Omega$ |
| I_D | -20 | A |

Applications

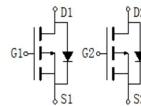
Power switching application

Hard Switched and High Frequency Circuits

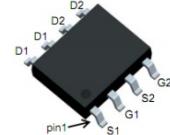
Uninterruptible Power Supply



SOP8 Top view



Schematic diagram

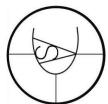


Package Marking And Ordering Information

| Part ID | Package Type | Marking | Tape and Reel information |
|-----------|--------------|-----------|---------------------------|
| UV30P10MS | SOP-8 | UV30P10MS | 3000pcs/Reel |

Maximum ratings, at $T_j=25^\circ C$, unless otherwise specified

| Symbol | Parameter | Rating | Unit |
|---------------|---|------------------|------|
| $V_{(BR)DSS}$ | Drain –Source breakdown voltage | -30 | V |
| I_D | Continuous drain current | $T_c=25^\circ C$ | -40 |
| | | $T_c=75^\circ C$ | -28 |
| I_{DM} | Pulse drain current tested① | $T_c=25^\circ C$ | -68 |
| E_{AS} | Avalanche energy, single pulsed② | 45 | mJ |
| P_D | Maximum power dissipation | $T_c=25^\circ C$ | 2.8 |
| V_{GS} | Gate-Source voltage | ± 20 | V |
| $T_{STG} T_J$ | Storage and operating temperature range | -55 to 150 | °C |



UV30P10MS
-30V -20A Dual P-Channel Mosfet

Thermal Characteristic

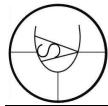
| Symbol | Parameter | Typical | Unit |
|-----------|--|---------|------|
| R_{QJC} | Thermal Resistance-Junction to Case | 0.8 | °C/W |
| R_{QJA} | Thermal Resistance-Junction to Ambient | 40 | °C/W |

Typical Characteristics

| Symbol | Parameter | Condition | Min | Type | Max | Unit |
|---|--|---|------|------|-----------|------------------|
| Static Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise stated) | | | | | | |
| $V_{(\text{BR})DSS}$ | Drain-Source Breakdown Voltage | $V_{GS}=0\text{V}$ $I_D=250\mu\text{A}$ | -30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$ | | | 1 | μA |
| | Zero Gate Voltage Drain Current($T_j=100^\circ\text{C}$) | $V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$ | | | 10 | μA |
| I_{GSS} | Gate-Body Leakage Current | $V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$ | | | ± 100 | nA |
| $V_{GS(\text{TH})}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$ | -1.2 | -1.7 | -2.5 | V |
| $R_{DS(\text{ON})}$ | Drain-Source On-State Resistance ^③ | $V_{GS}=-10\text{V}$, $I_D=-12\text{A}$ | | 12.5 | 13.5 | $\text{m}\Omega$ |
| | | $V_{GS}=-4.5\text{V}$, $I_D=-6\text{A}$ | | 16.5 | 18.5 | $\text{m}\Omega$ |
| Dynamic Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise stated) | | | | | | |
| C_{iss} | Input Capacitance | $V_{DS}=-15\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$ | | 2350 | | PF |
| C_{oss} | Output Capacitance | | | 330 | | PF |
| C_{rss} | Reverse Transfer Capacitance | | | 139 | | PF |
| Q_g | Total Gate Charge | $V_{DS}=-15\text{V}$, $I_D=-8\text{A}$, $V_{GS}=-10\text{V}$ | | 29.8 | | nC |
| Q_{gs} | Gate-Source Charge | | | 14 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 10 | | nC |
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-on Delay time | $V_{DD}=-15\text{V}$ $I_D=-8\text{A}$ $R_G=6\ \Omega$ $V_{GS}=-10\text{V}$ | | 11 | | nS |
| t_r | Turn-on Rise time | | | 9 | | nS |
| $t_{d(off)}$ | Turn-off Delay time | | | 25 | | nS |
| t_f | Turn-off Fall time | | | 13 | | nS |
| Source-Drain Diode Characteristics | | | | | | |
| V_{SD} | Forward on voltage | $I_{SD}=-3.5\text{A}$, $V_{GS}=0\text{V}$ | | | -1.2 | V |
| Trr | Reverse Recovery Time | $I_{SD}=-5\text{A}$ $V_{GS}=0\text{V}$ $di/dt=100\text{A}/\mu\text{s}$ | | 39 | | nS |
| Qrr | Reverse Recovery Charge | | | 22 | | nC |

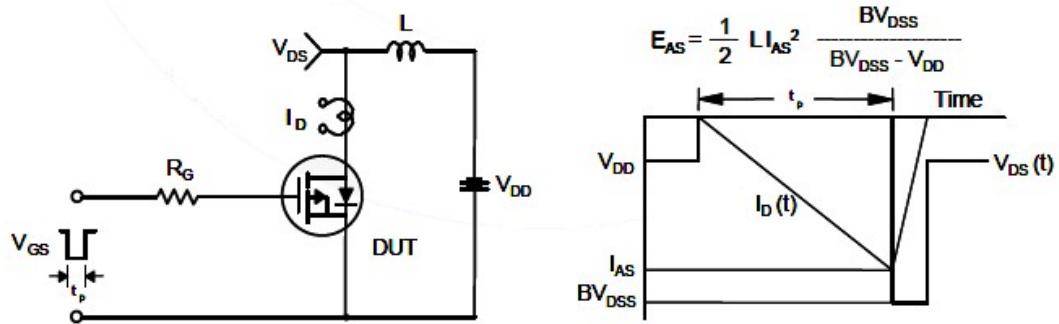
Note:

- ① Repetitive rating; pulse width limited by max, junction temperature.
- ② Limited by $T_{j\max}$, starting $T_j=25^\circ\text{C}$, $L=0.1\text{mH}$, $R_G=6\ \Omega$, $I_{AS}=-6\text{A}$, $V_{DD}=-24\text{V}$, Part not recommended for use above this value
- ③ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$

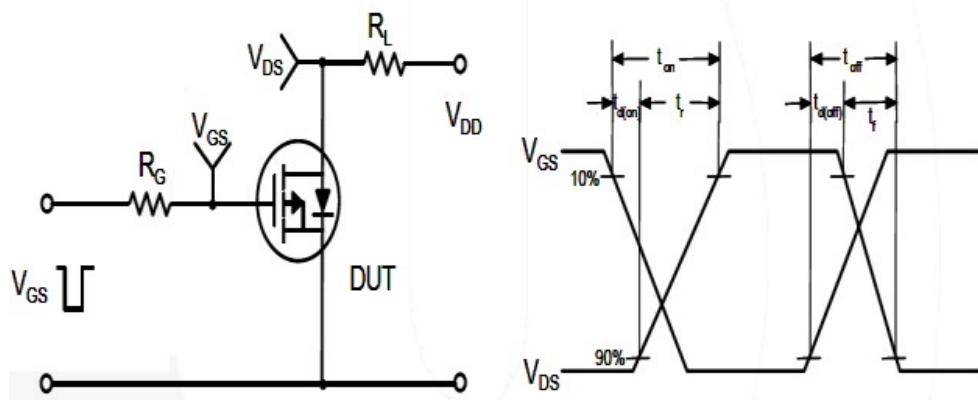


Test circuit

(1) Unclamped inductive test circuits and waveforms



(2) Switching time test circuit and waveforms



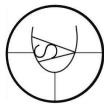


Fig 1. Typical Output Characteristics

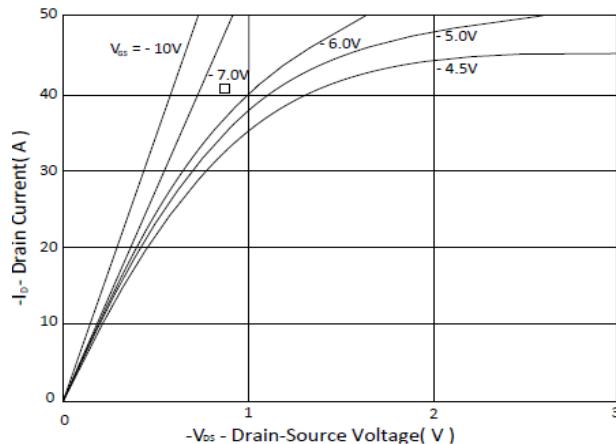


Figure 2. On-Resistance vs. Gate-Source Voltage

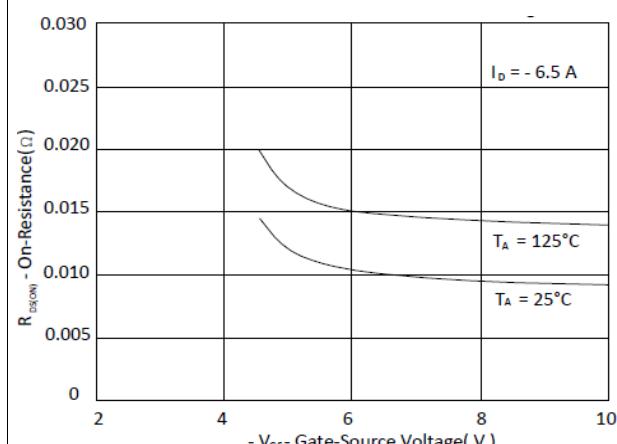


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

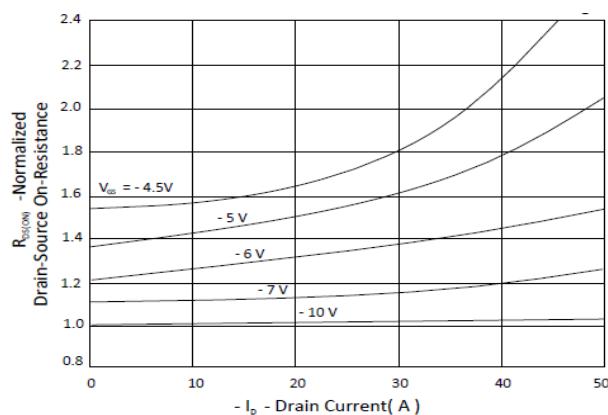


Figure 4. Normalized On-Resistance vs. Junction Temperature

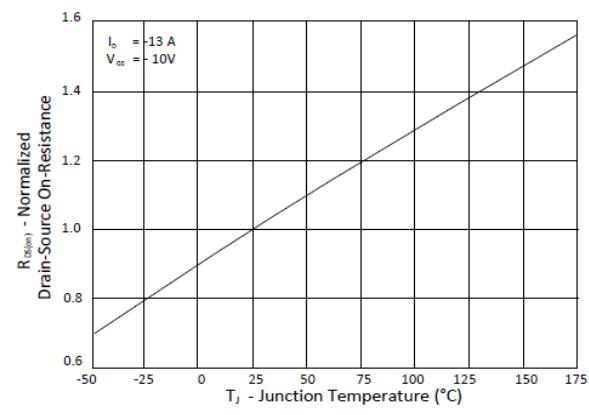


Figure 5. Typical Transfer Characteristics

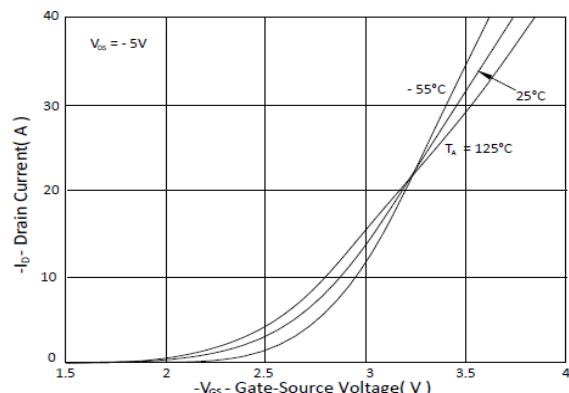
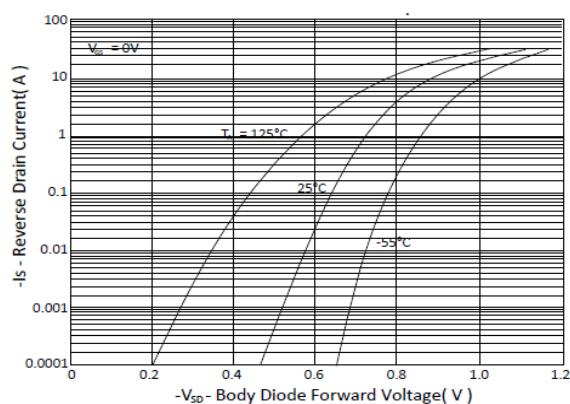


Figure 6. Typical Source-Drain Diode Forward Voltage



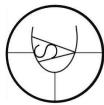


Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

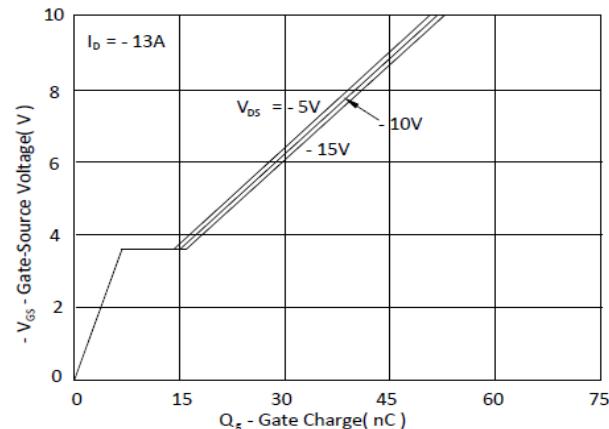


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

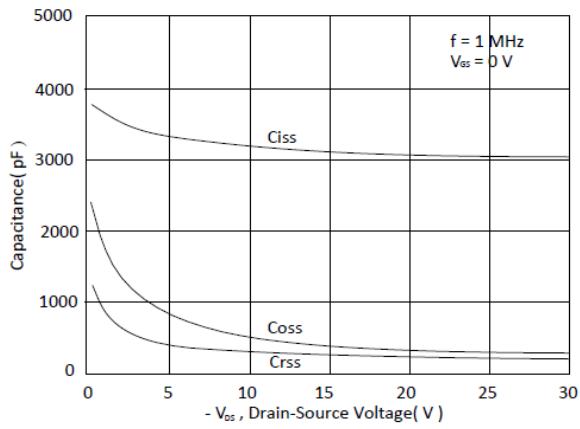


Figure 9. Maximum Safe Operating Area

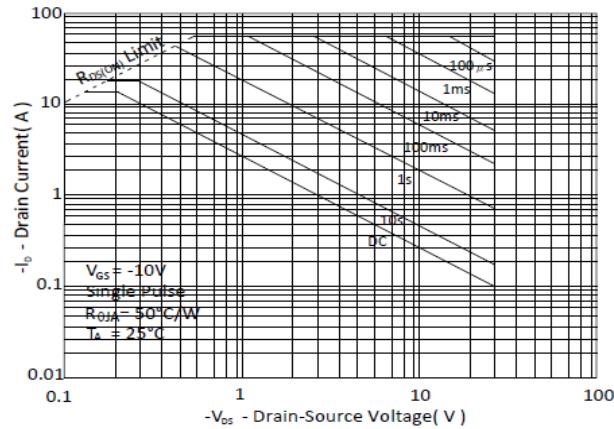


Figure 10. Single Pulse Maximum Power Dissipation

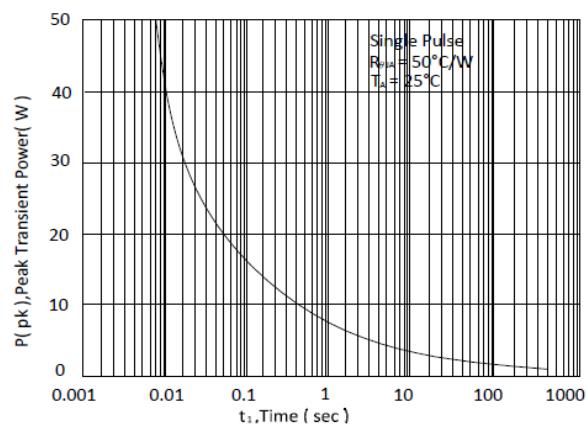
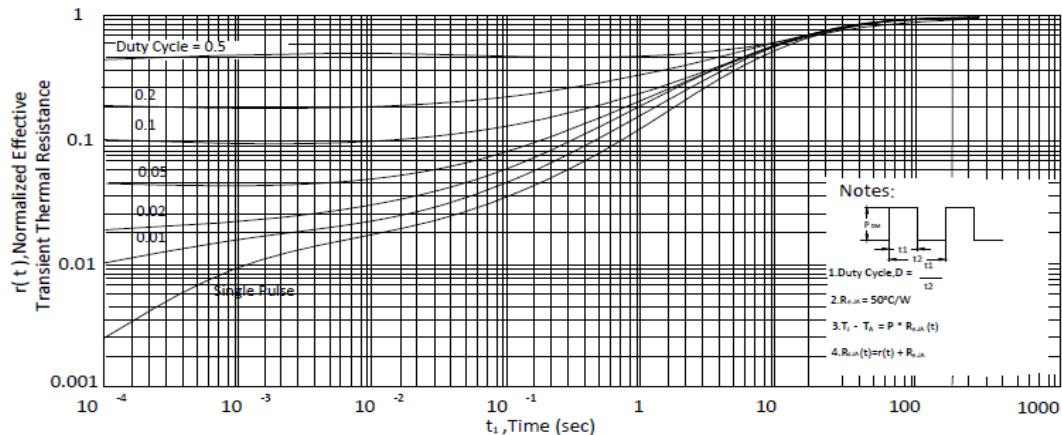
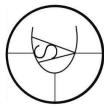


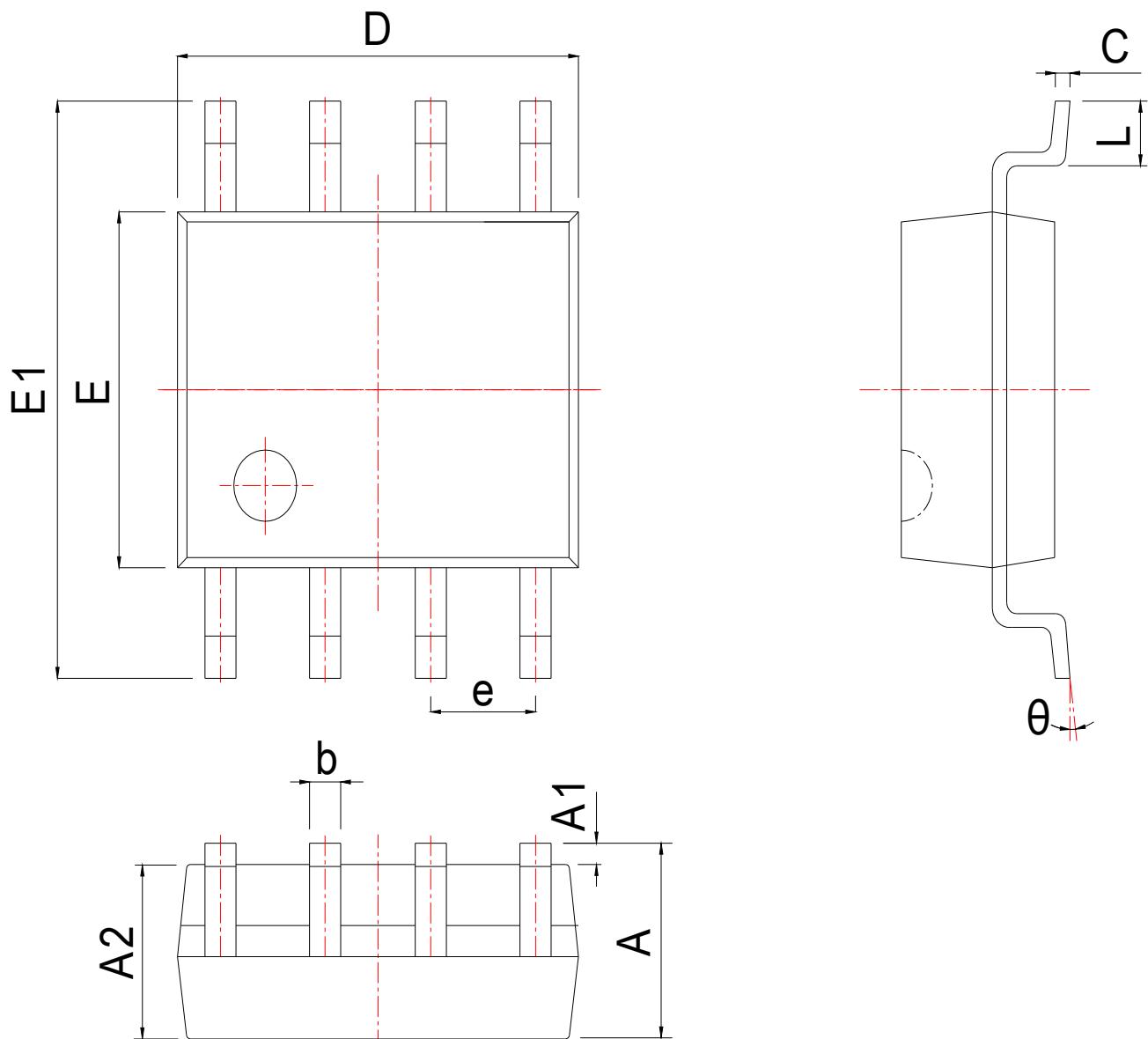
Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Ambient





Package Information

SOP-8



| SYMBOL | MM | | | INCH | | |
|--------|-----------|-------|-------|-----------|-------|-------|
| | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 1.300 | 1.525 | 1.750 | 0.051 | 0.060 | 0.069 |
| A1 | 0.050 | 0.150 | 0.250 | 0.002 | 0.006 | 0.010 |
| A2 | 1.350 | 1.450 | 1.550 | 0.053 | 0.057 | 0.061 |
| b | 0.330 | 0.420 | 0.510 | 0.013 | 0.017 | 0.020 |
| c | 0.170 | 0.210 | 0.250 | 0.007 | 0.008 | 0.010 |
| D | 4.700 | 4.900 | 5.100 | 0.185 | 0.193 | 0.201 |
| E | 3.800 | 3.900 | 4.000 | 0.150 | 0.154 | 0.157 |
| E1 | 5.800 | 6.000 | 6.200 | 0.228 | 0.236 | 0.244 |
| e | 1.270 BSC | | | 0.050 BSC | | |
| L | 0.400 | 0.835 | 1.270 | 0.016 | 0.033 | 0.050 |
| θ | 0° | | 8° | 0° | | 8° |